

### N-Channel Enhancement-Mode MOSFET (85V, 120A)

#### PRODUCT SUMMARY

$V_{DSS}$	$I_D$	$R_{DS(on)}$ (m $\Omega$ ) Max
85V	100A	5.5 @ $V_{GS} = 10\text{V}, I_D = 50\text{A}$

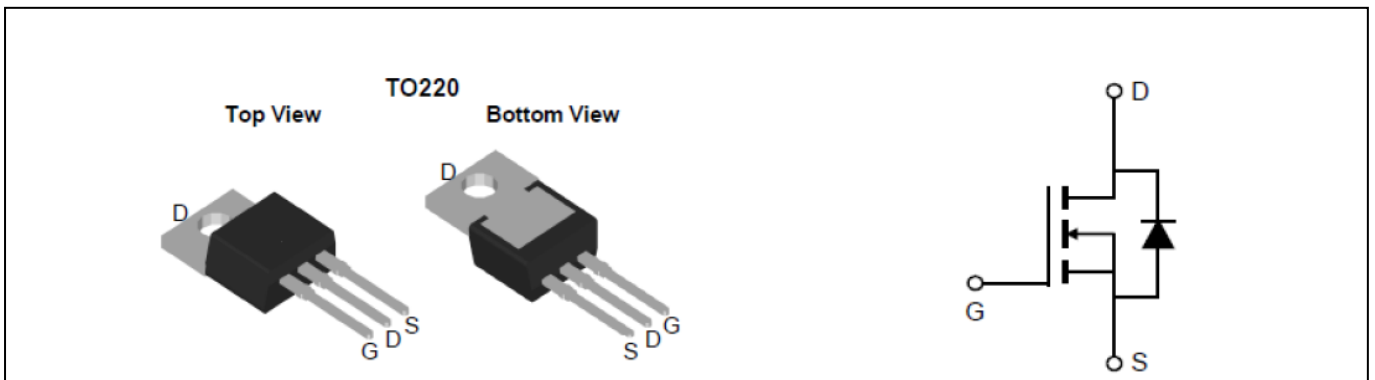
#### Features

- Special process technology for high ESD capability
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation
- Ordering information: GA120N08 - (Lead (Pb) - free and halogen - free)
- High density cell design for ultra low  $R_{DS(on)}$
- Good stability and uniformity with high EAS

#### Application

- Motor Drives
- DC/DC converter
- UPS (Uninterruptible Power Supplies)
- General purpose applications

RoHS+HF



#### Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain-Source Voltage	85	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current (Continuous)	120	A
$I_{DM}$	Drain Current (Pulsed)	480	A
$P_D$	Total Power Dissipation @ $T_C = 25^\circ\text{C}$	180	W
$T_j, T_{stg}$	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$I_{AS}$	Avalanche Current with Single Pulse ( $L = 0.5\text{mH}$ )	24	A
$E_{AS}$	Avalanche Energy with Single Pulse ( $L = 0.5\text{mH}$ )	144	mJ
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	62.5	$^\circ\text{C}/\text{W}$

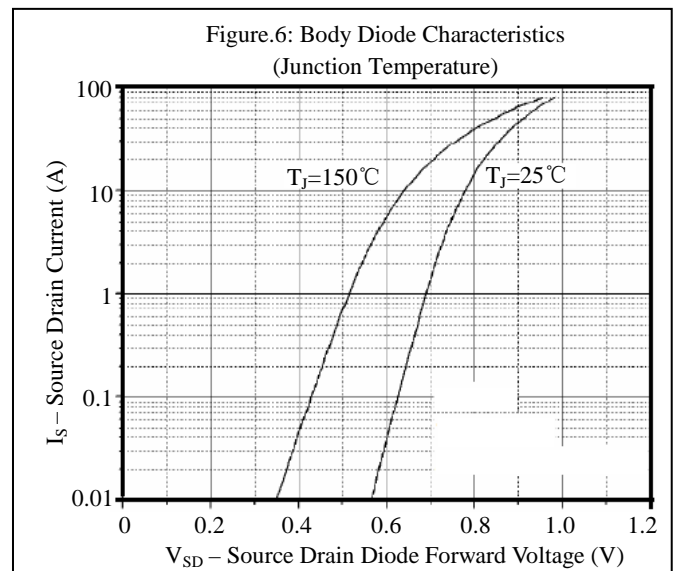
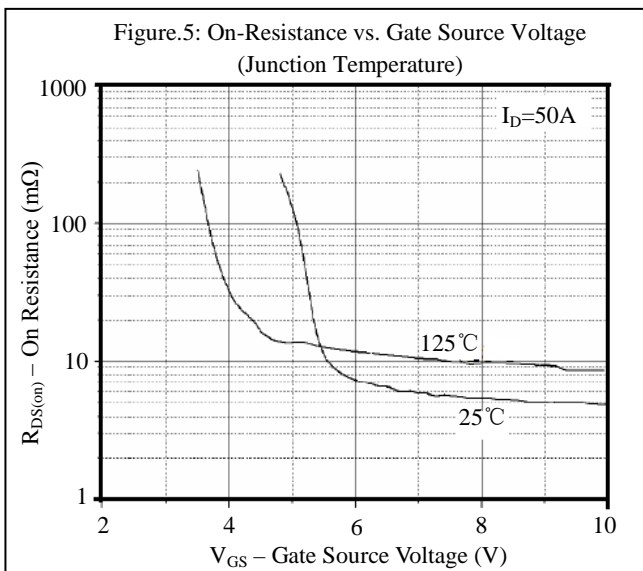
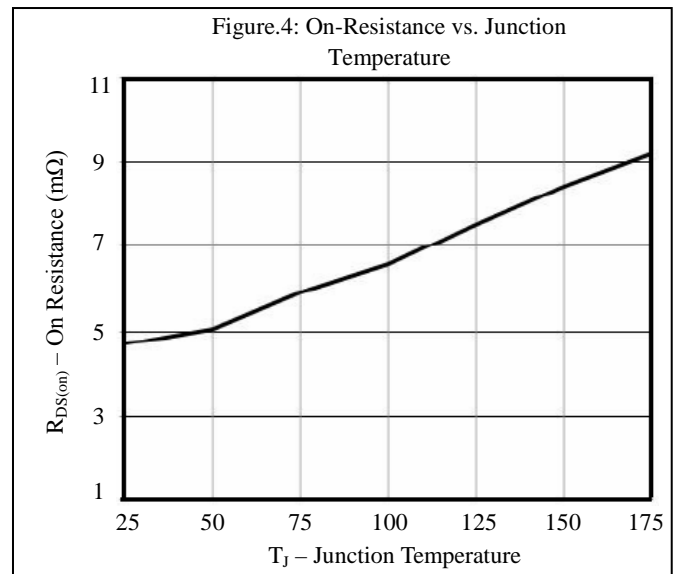
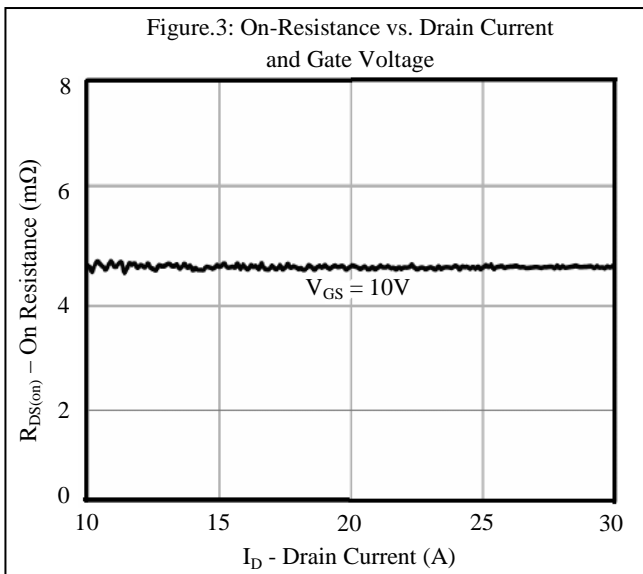
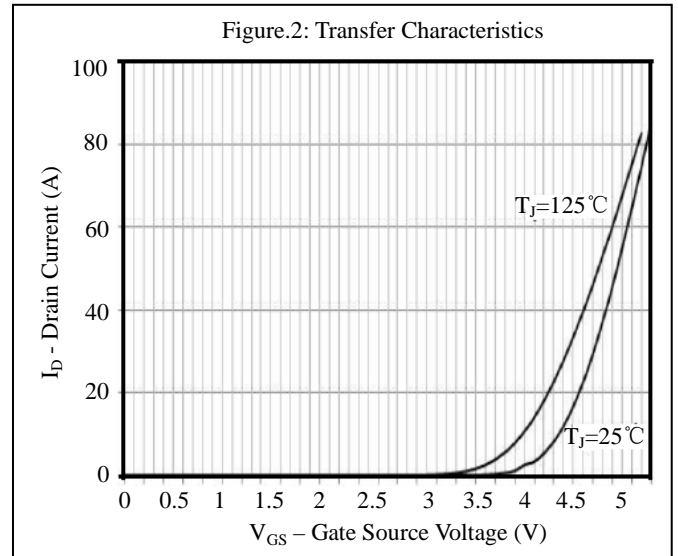
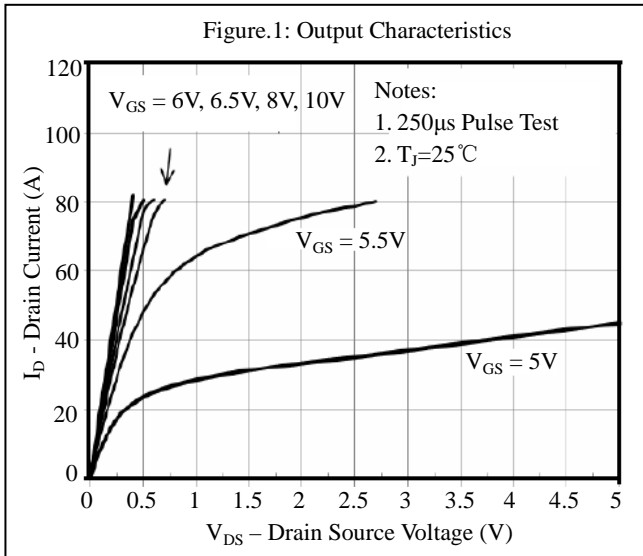
### Electrical Characteristics (T<sub>A</sub>=25°C, unless otherwise noted)

Symbol	Characteristic	Test Conditions	Min.	Typ.	Max.	Unit
<b>• Off Characteristics</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	100	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =64V, V <sub>GS</sub> =0V	-	-	1	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	-	-	±100	nA
<b>• On Characteristics<sup>c</sup></b>						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2	-	4	V
R <sub>DS(on)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =50A	-	4.6	5.5	mΩ
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f= 1MHz	-	3.3	-	Ω
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =50V, I <sub>D</sub> =20A	-	80	-	S
<b>• Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =40V, V <sub>GS</sub> =0V, f=1MHz	-	3070	-	pF
C <sub>oss</sub>	Output Capacitance		-	1050	-	
C <sub>rss</sub>	Reverse Transfer Capacitance		-	28	-	
<b>• Switching Characteristics</b>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =40V, I <sub>D</sub> =50A, V <sub>GS</sub> =10V	-	55	-	nC
Q <sub>gs</sub>	Gate-Source Charge		-	15	-	
Q <sub>gd</sub>	Gate-Drain Charge		-	13	-	
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DS</sub> =40V, R <sub>L</sub> =3Ω, I <sub>D</sub> =20A, V <sub>GS</sub> =10V, R <sub>G</sub> =10Ω	-	20	-	nS
t <sub>r</sub>	Turn-on Rise Time		-	38	-	
t <sub>d(off)</sub>	Turn-off Delay Time		-	45	-	
t <sub>f</sub>	Turn-off Fall Time		-	23	-	
<b>• Drain-Source Diode Characteristics</b>						
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>SD</sub> =50A	-	-	1.4	V

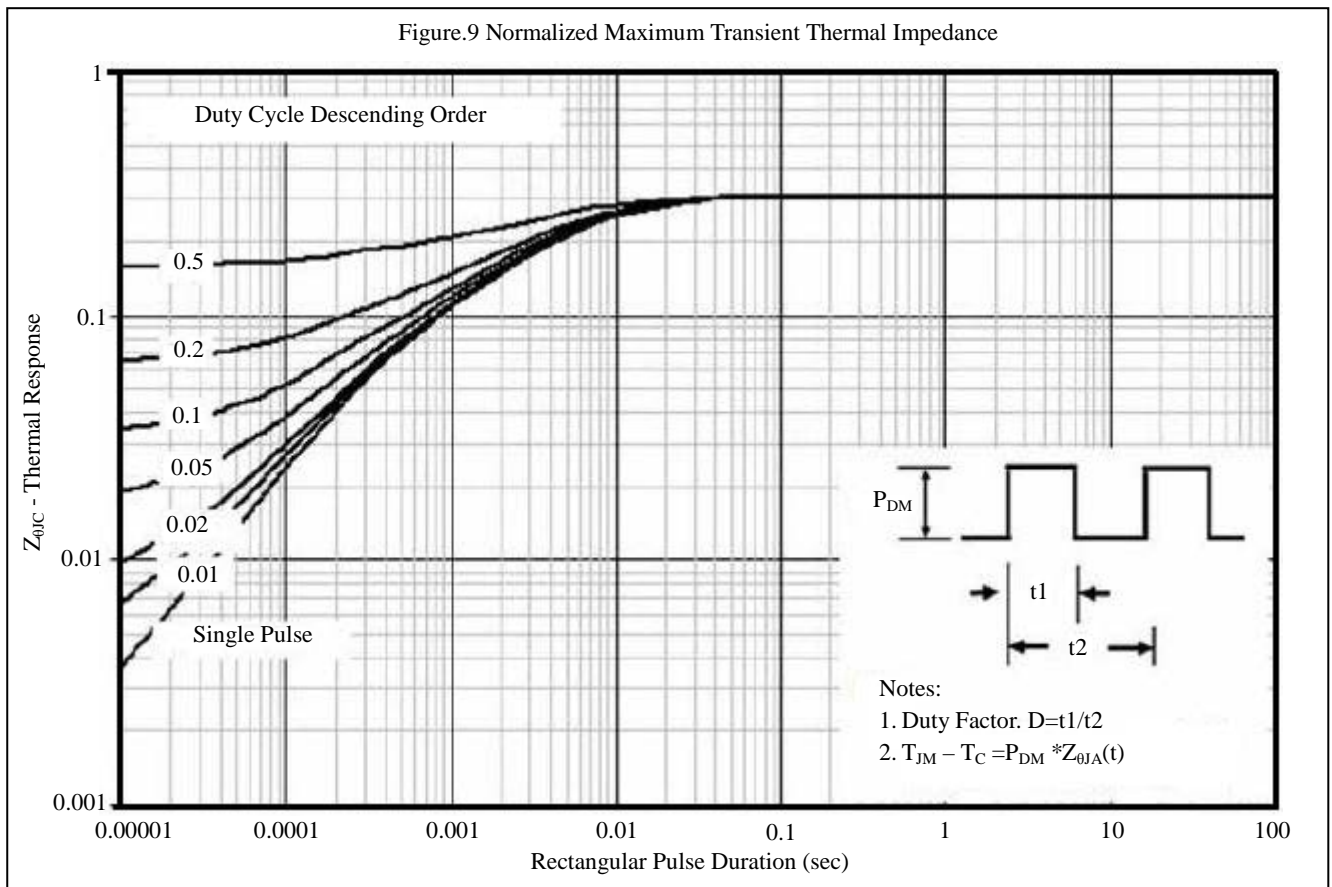
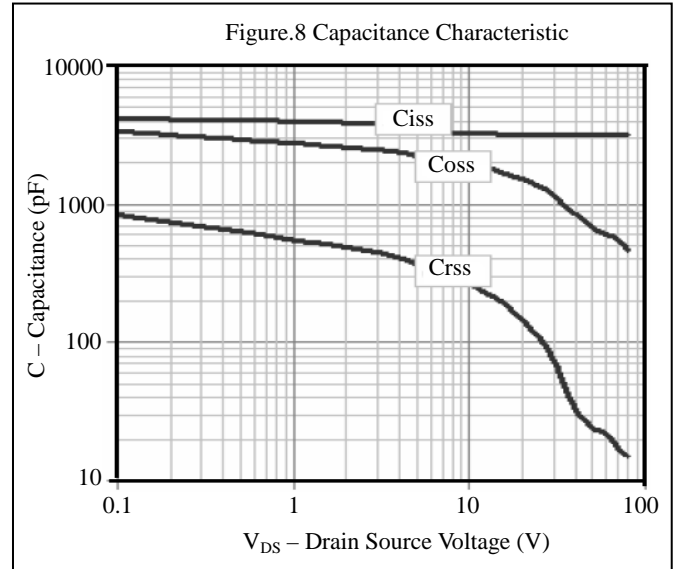
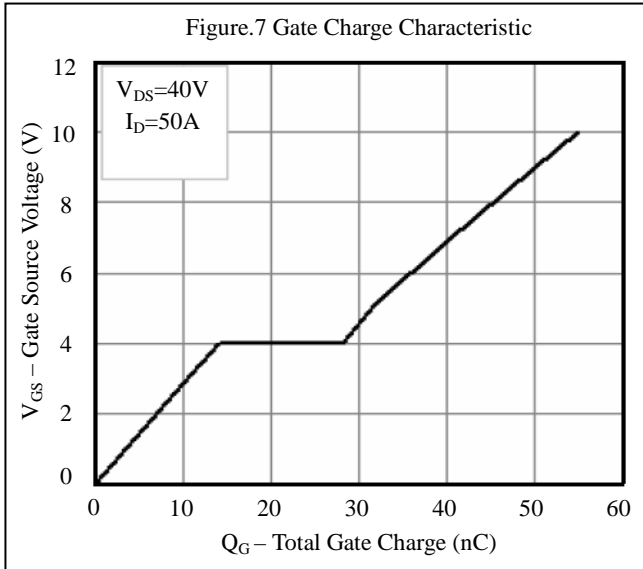
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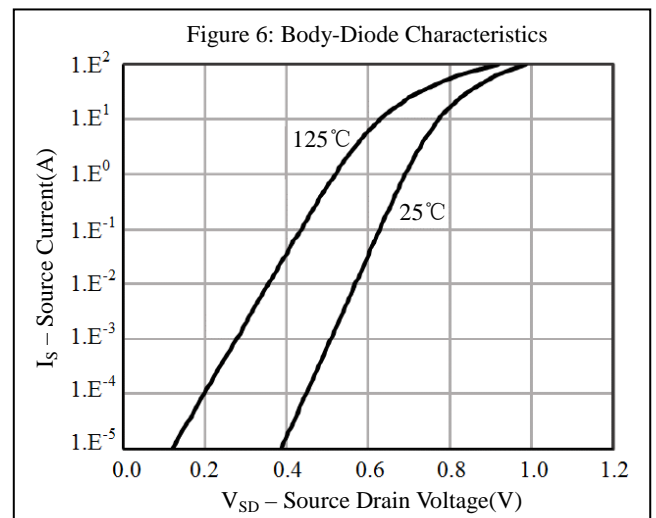
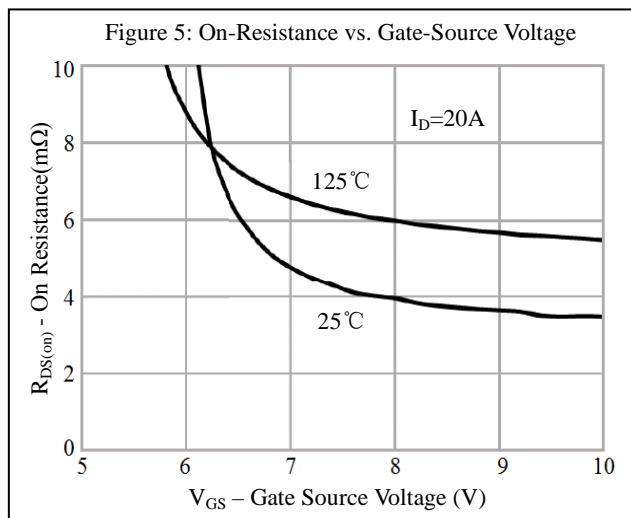
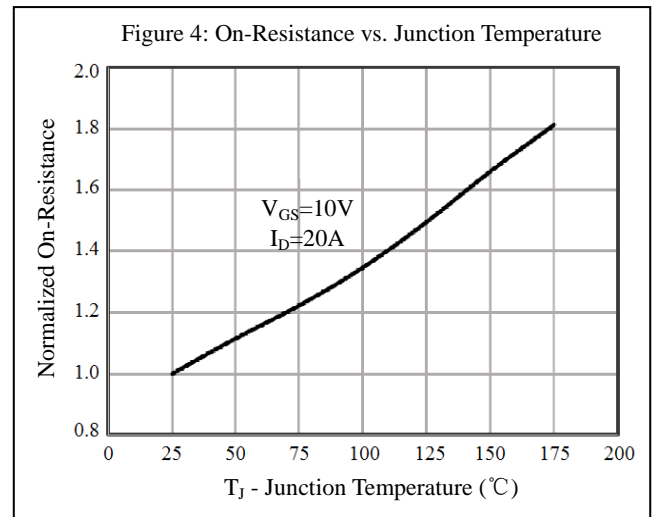
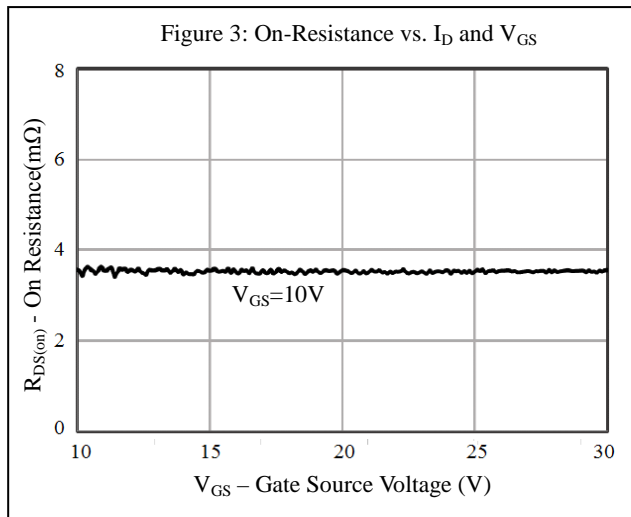
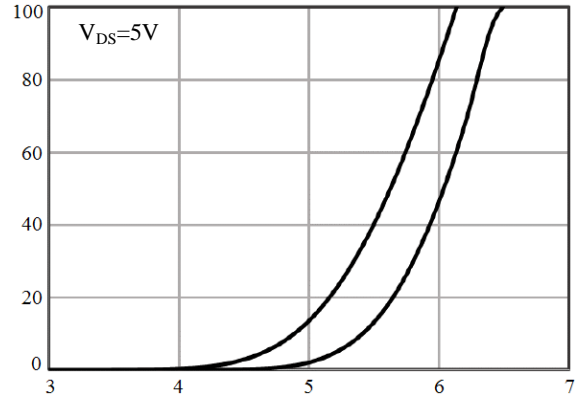
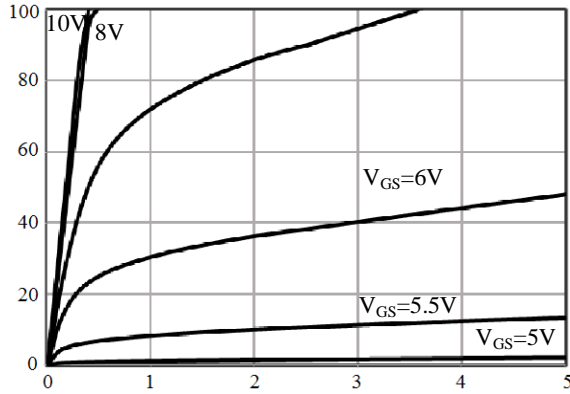
c: Guaranteed by design , not subject to production testing .

### Typical Performance Characteristics

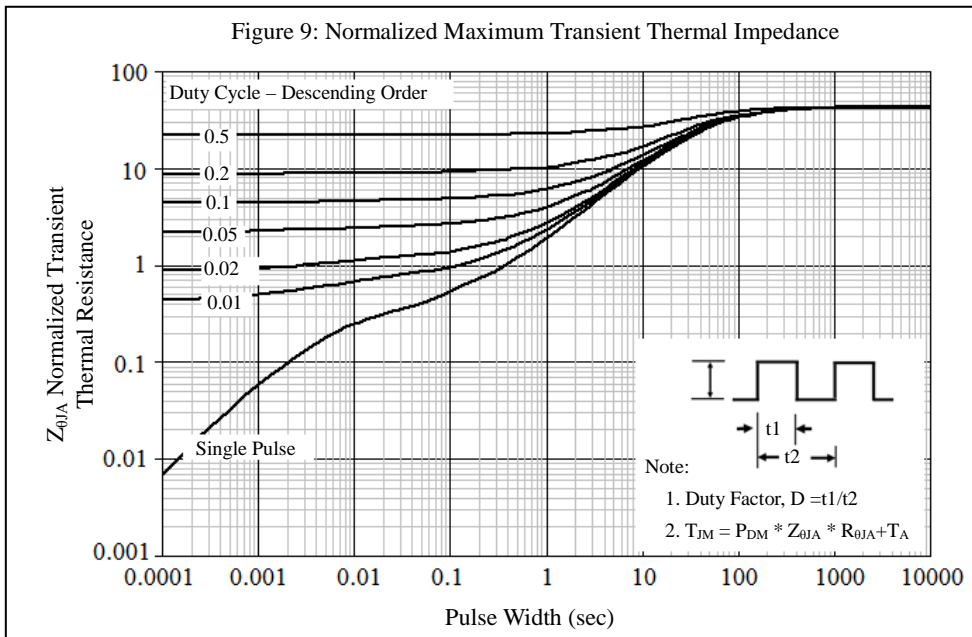
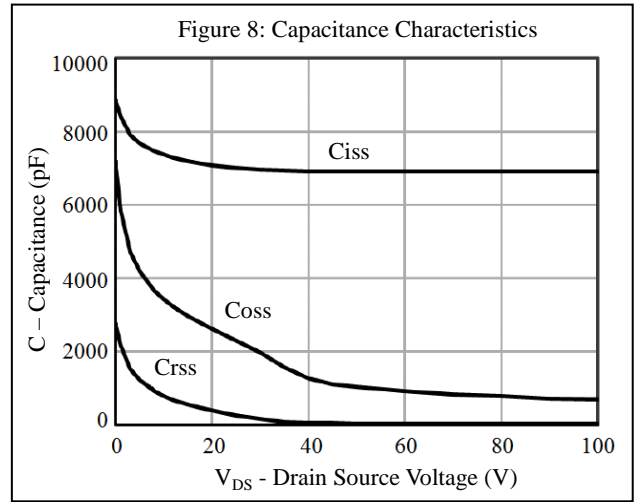
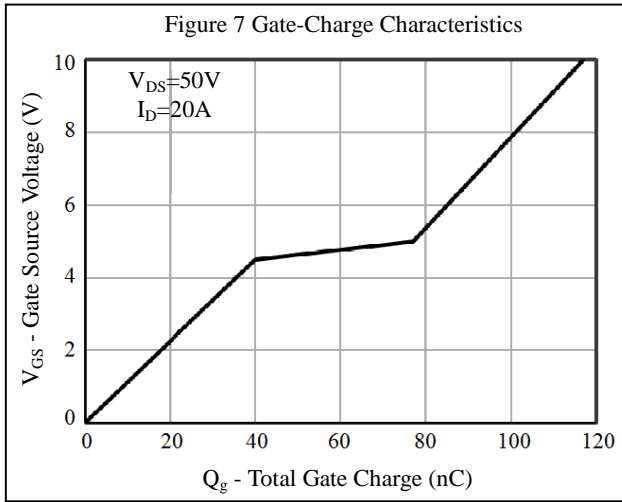


### Typical Performance Characteristics



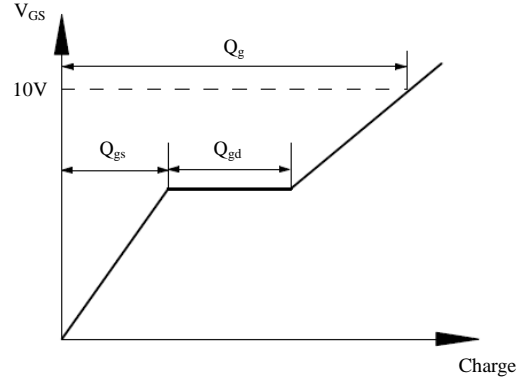
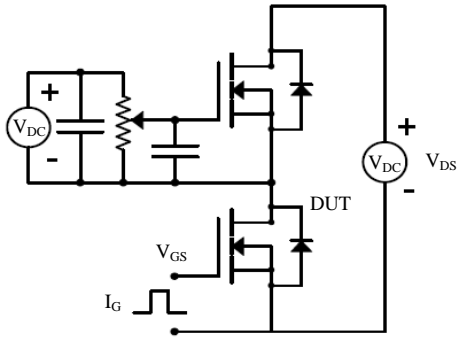


## Typical Performance Characteristics

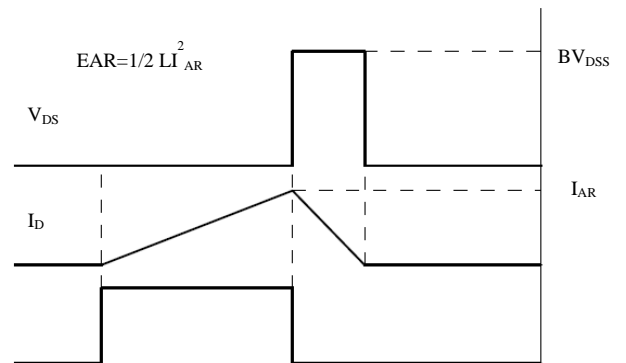
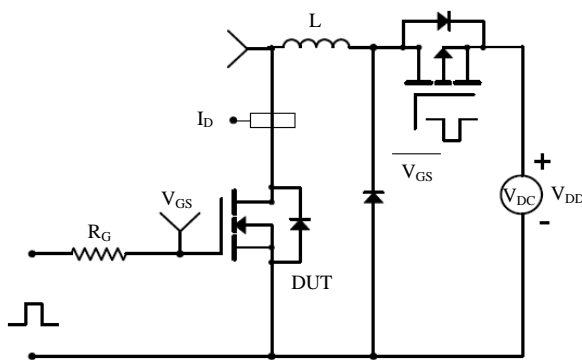
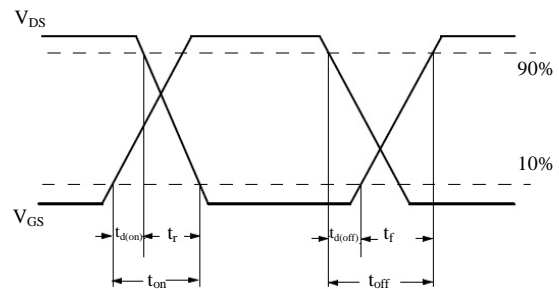
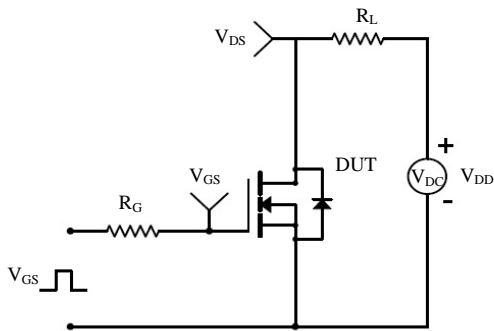


### Test Circuit & Waveform

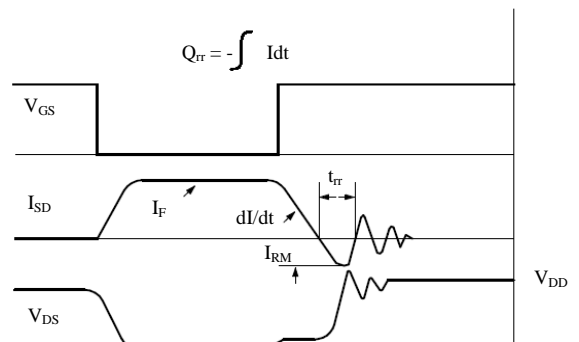
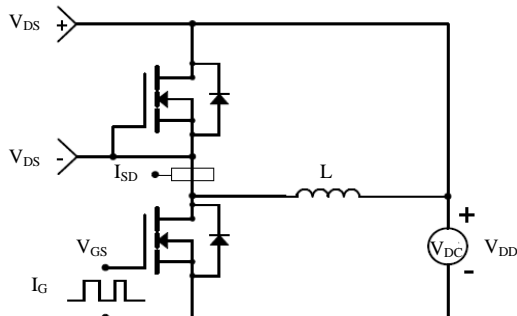
Gate Charge Test Circuit & Waveform



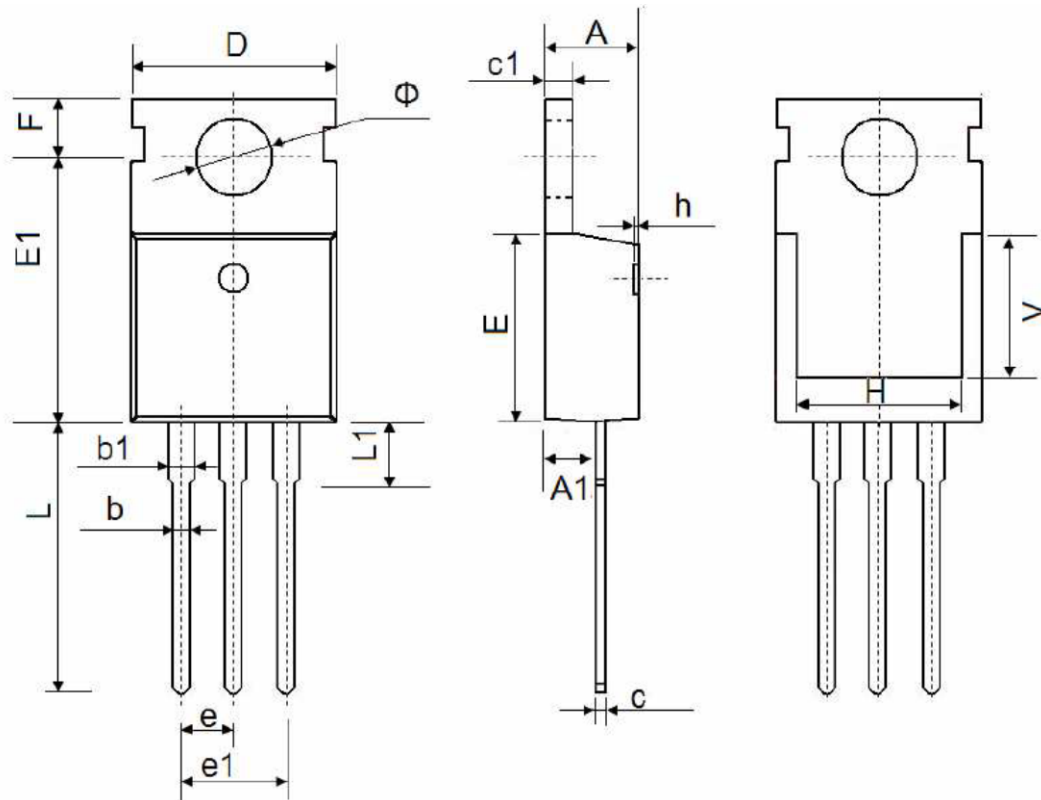
Resistive Switching Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



### Package Outline: TO-220-3L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
c	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.9500	9.750	0.352	0.384
E1	12.650	12.950	0.498	0.510
e	2.540 TYP.		0.100 TYP.	
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
H	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112	0.128
V	7.500 REF		0.295 REF	
Φ	3.400	3.800	0.134	0.150





### Notice

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